Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10822064	MEYER ET AL.
Examiner	Art Unit
/Chang, Rick K	3726

SEARCHED					
Class	Subclass	Date	Examiner		
29	832,834	11/25/07	rc		
257	737,738,778,723				
438	108,115,118,666				
	search updated	2/16/09			

SEARCH NOTES			
Search Notes	Date	Examiner	
east search	11/25/07	rc	
	2/16/09	rc	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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